

**Search Notes**

Application/Control No.

10/585,863

Examiner

YONG D. PAK

Applicant(s)/Patent under  
Reexamination

GAO ET AL.

Art Unit

1652

**SEARCHED**

Class	Subclass	Date	Examiner

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
stic: seq id no:2 and 9, see SCORE	6/11/2009	YP
EAST (all databases): text & inventor search, see search history	6/11/2009	YP
PALM: search of all inventors	6/11/2009	YP